

Title of Change:	NCV4266-2C datasheet update						
Effective date:	15 June 2018						
Contact information:	Contact your local ON Semiconductor Sales Office or <miroslav.hukel@onsemi.com></miroslav.hukel@onsemi.com>						
Type of notification:	This Product Bulletin is for notification purposes only. ON Semiconductor will proceed with implementation of this change upon publication of this Product Bulletin.						
Change category:	🔲 Wafe	r Fab Change	Test Change	Change I Other Datasheet update			
Change Sub-Category(s): Manufacturing Site Change/Addition Manufacturing Process Change Product specific change			 Datasheet/Product Doc change Shipping/Packaging/Marking Other: 				
Sites Affected:	ON Semiconductor Sites: Extern None None			nal Foundry/Subcon Sites:			
Description and Purpose:							
Tightening the "Enable Voltage, Output High" max limit from 2.8V to 2.7V.							
From (June, 2017 – Rev. 1): ELECTRICAL CHARACTERISTICS table, Page 3:							
Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit]
ENABLE INPUT	•		•		•	•	
Enable Voltage, Output High	VEN	$V_Q \ge V_{QMIN}$	-	2.0	2.8	V	
Enable Voltage, Output Low (Off)	V _{EN}	$V_Q \le 0.1 V$	0.8	1.8	-	V]
To (June, 2018 – Rev. 2): ELECTRICAL CHARACTERISTICS table, Page 3:							
Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit	
ENABLE INPUT	•	•	•	•			
Enable Voltage, Output High	V _{EN}	$V_Q \ge V_{QMIN}$	-	2.0	2.7	V	
Enable Voltage, Output Low (Off)	V _{EN}	$V_Q \le 0.1 V$	0.8	1.8	-	V	
The change will not impact form, fit, or function of products.							
List of Affected Standard Parts:							
NCV4266-2CST50T3G NCV4266-2CST33T3G							